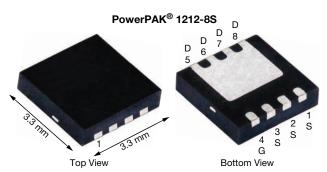


Vishay Siliconix

N-Channel 80 V (D-S) MOSFET



PRODUCT SUMMARY			
V _{DS} (V)	80		
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.008		
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 7.5 \text{ V}$	0.0093		
Q _g typ. (nC)	14.2		
I _D (A)	58.1		
Configuration	Single		

FEATURES

- TrenchFET® Gen V power MOSFET
- Very low R_{DS} x Q_g figure-of-merit (FOM)
- Tuned for the lowest R_{DS} x Q_{oss} FOM

• 100 % R_a and UIS tested

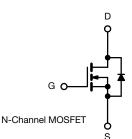
 Material categorization: for definitions of compliance please see www.vishav.com/doc?99912



ROHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- Synchronous rectification
- · Primary side switch
- DC/DC converters
- · OR-ing and hot swap switch
- Power supplies
- Motor drive control
- Battery management



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ORDERING INFORMATION	
Package	PowerPAK 1212-8S
Lead (Pb)-free and halogen-free	SISS588DN-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V _{DS}	80	V
Gate-source voltage		V _{GS}	± 20	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		58.1	
	T _C = 70 °C		46.5	
	T _A = 25 °C	I _D	16.9 ^{b, c}	
	T _A = 70 °C		13.5 ^{b, c}	
Pulsed drain current (t = 100 µs)		I _{DM}	150	A
Continuous source-drain diode current	T _C = 25 °C		51.6	
	T _A = 25 °C	l _S	4.3 b, c	
Single pulse avalanche current	. 0.1	I _{AS}	25	
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	31.25	mJ
Maximum power dissipation	T _C = 25 °C		56.8	
	T _C = 70 °C		36.3	10/
	T _A = 25 °C	P _D	4.8 b, c	W
	T _A = 70 °C		3 b, c	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C
Soldering recommendations (peak temperature) c			260	

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient ^b	t ≤ 10 s	R _{thJA}	21	26	°C/W	
Maximum junction-to-case (drain)	Steady state	R _{thJC}	1.8	2.2	C/VV	

Notes

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8S is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- f. Maximum under steady state conditions is 70 °C/W
- g. $T_C = 25$ °C



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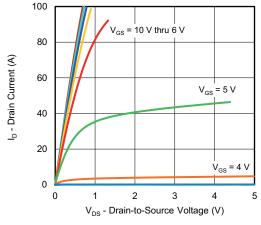
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	V _{GS} = 0 V, I _D = 1 mA	80	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	42	-	m\//00	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-6	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	-	4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zero gate voltage drain current		V _{DS} = 64 V, V _{GS} = 0 V	-	-	1		
	I _{DSS}	V _{DS} = 64 V, V _{GS} = 0 V, T _J = 70 °C	-	-	10	μA	
Drain-source on-state resistance ^a	5	V _{GS} = 10 V, I _D = 10 A	-	0.00630	0.00800	Ω	
	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	0.00720	0.0093		
Forward transconductance a	9 _{fs}	V _{DS} = 10 V, I _D = 10 A	-	32	-	S	
Dynamic ^b			- I				
Input capacitance	C _{iss}		-	1380	-	pF	
Output capacitance	C _{oss}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	390	-		
Reverse transfer capacitance	C _{rss}		-	6.6	-		
Talah sala akana	0	V _{DS} = 40 V, V _{GS} = 10 V, I _D = 10 A	-	18.7	18.7 28.5	nC	
Total gate charge	Q_g	$V_{DS} = 40 \text{ V}, V_{GS} = 7.5 \text{ V}, I_{D} = 10 \text{ A}$	-	14.2	21.5		
Gate-source charge	Q_{gs}		-	6.6	-		
Gate-drain charge	Q _{gd}		-	2.1	-		
Output charge	Q _{oss}	V _{DS} = 40 V, V _{GS} = 0 V	-	40	-		
Gate resistance	R_{g}	f = 1 MHz	0.5	1.0	1.8	Ω	
Turn-on delay time	t _{d(on)}		-	13	26		
Rise time	t _r	$V_{DD} = 40 \text{ V}, R_1 = 4 \Omega$	-	5	10		
Turn-off delay time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	18	36		
Fall time	t _f		-	6	12		
Turn-on delay time	t _{d(on)}		-	15	30	ns	
Rise time	t _r	$V_{DD} = 40 \text{ V}, R_{L} = 4 \Omega$	-	6	12		
Turn-off delay time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$	-	18	36		
Fall time	t _f		-	6	12		
Drain-Source Body Diode Characteristic	s		- I				
Continuous source-drain diode current	IS	T _C = 25 °C -	-	51.6			
Pulse diode forward current ($t_p = 100 \mu s$)	I _{SM}		-	-	150	Α	
Body diode voltage	V_{SD}	I _S = 5 A	-	0.78	1.1	V	
Body diode reverse recovery time	t _{rr}		-	36	72	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	32	64	nC	
Reverse recovery fall time	ta	$T_J = 25 ^{\circ}\text{C}$	-	18	-	ns	
Reverse recovery rise time	t _b		_	18	-		

Notes

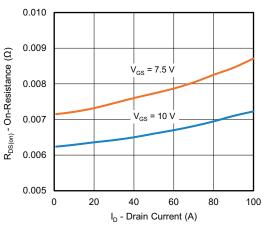
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

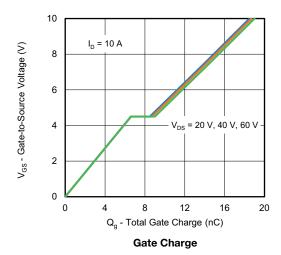


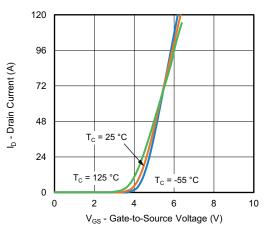




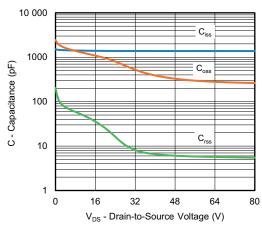


On-Resistance vs. Drain Current

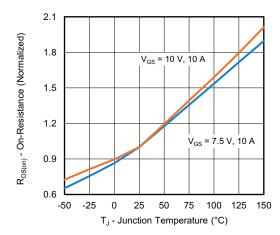




Transfer Characteristics

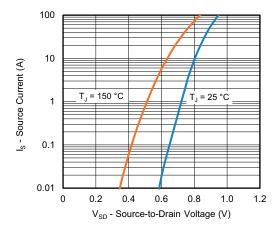


Capacitance

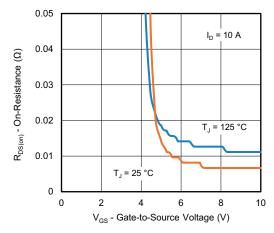


On-Resistance vs. Junction Temperature

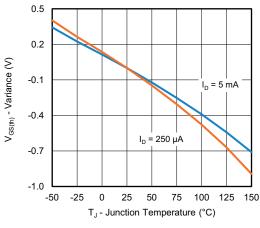




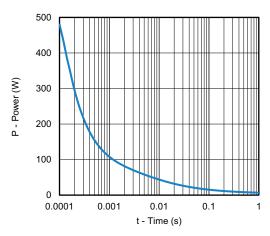
Source-Drain Diode Forward Voltage



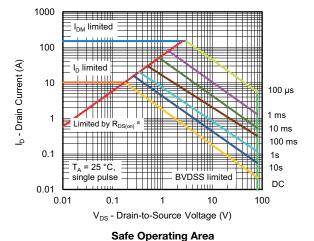
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



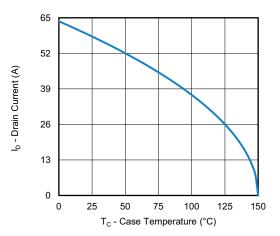
Single Pulse Power, Junction-to-Ambient



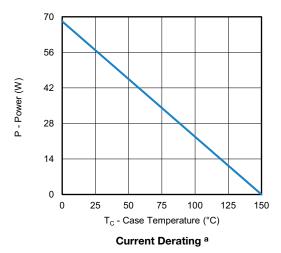
Note

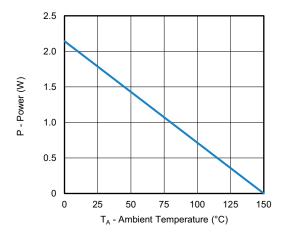
a. $V_{GS} > minimum V_{GS}$ at which $R_{DS(on)}$ is specified





Power, Junction-to-Case



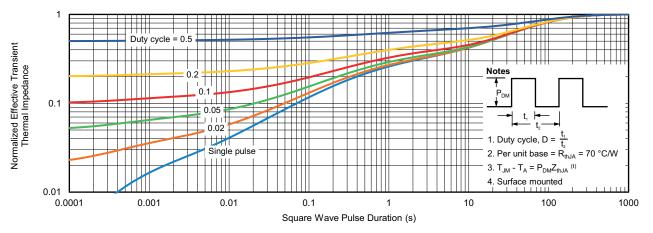


Power, Junction-to-Ambient

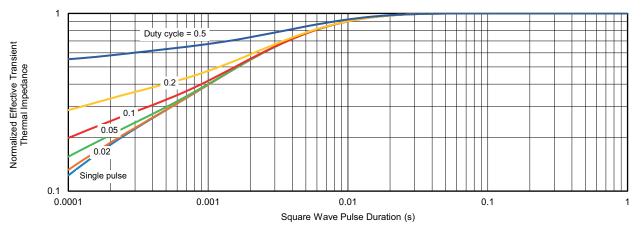
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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